

Search Notes

Application/Control No.

10/821,505

Examiner

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Applicant(s)/Patent under
Reexamination

HUANG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	4	5/30/2006	JSL
716	5	5/30/2006	JSL
716	6	5/30/2006	JSL
702	181	5/30/2006	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	4	5/30/2006	JSL
716	5,6	5/30/2006	JSL
702	181	5/30/2006	JSL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB]	5/30/2006	JSL
IEEE	5/30/2006	JSL
GOOGLE	5/30/2006	JSL